

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/990,558	CHOI ET AL.
	Examiner	Art Unit
	John L. Shew	2664

SEARCHED			
Class	Subclass	Date	Examiner
370	320,329	10/11/2005	JS
	331,332		
	335,336		
	337,342		
	348,349		
	437,441		
455	432.1	10/11/2005	JS
	432.3		
	433,436		
	439,442		
	450,452		